

RX Family, H8S Family

R01AN4045EJ0100

Rev.1.00

H8S to RX Migration Guide: External Bus

Nov 08, 2017

Summary

This application note explains how to migrate between the external bus functions of the RX Family and H8S Family.

Target Devices

- RX Family
- H8S Family

An example of migrating from the H8S Family to the RX Family is presented, with the RX Family represented by the RX231 Group and the H8S Family represented by the H8S/2378 Series. When using this application note with other microcontrollers, appropriate changes should be made to match the specifications of the microcontroller used and thorough evaluation should be performed.

Table Differences in Terminology between RX Family and H8S Family

| Item | RX Family | H8S Family |
|-------------------|----------------|------------|
| Name of bus clock | BCLK | ϕ |
| Idle cycle | Recovery cycle | Idle cycle |

Contents

| | |
|--|-----------|
| 1. Points of Difference between External Bus Functions | 3 |
| 1.1 External Bus Connection Examples | 4 |
| 1.1.1 16-Bit Bus Connection Examples..... | 4 |
| 1.1.2 8-Bit Bus Connection Examples..... | 5 |
| 1.2 Bus Timing Comparison..... | 6 |
| 1.3 Calculating Access Cycle Counts | 10 |
| 1.3.1 Calculating Access Cycle Counts for Read Accesses | 10 |
| 1.3.2 Calculating Access Cycle Counts for Write Accesses | 13 |
| 1.3.3 Idle Cycles (Recovery Cycles)..... | 16 |
| 2. Operating Modes | 17 |
| 2.1 Comparison of Operating Modes | 17 |
| 2.2 Functional Points of Difference between Operating Modes..... | 18 |
| 3. External Bus Setting Examples | 19 |
| 3.1 Points of Difference between Setting Procedures (On-Chip ROM Enabled Extended Mode Settings) | 19 |
| 3.2 Points of Difference between Setting Procedures (On-Chip ROM Disabled Extended Mode Settings) | 22 |
| 4. Appendix..... | 26 |
| 4.1 Key Points when Migrating from H8S to RX..... | 26 |
| 4.1.1 Interrupts | 26 |
| 4.1.2 I/O Ports | 27 |
| 4.1.3 Module Stop Function | 27 |
| 4.1.4 Register Write Protection Function..... | 27 |
| 4.2 I/O Register Macros | 28 |
| 4.3 Interrupt Functions | 28 |
| 5. Reference Documents..... | 29 |

1. Points of Difference between External Bus Functions

Table 1.1 Points of Difference between External Bus Functions (RX231 and H8S/2378)

| Item | RX (RX231) | | H8S (H8S/2378) |
|----------------------------------|---|-----------------------------------|--|
| Memory size | 16 MB (4 areas) | | 2 MB (8 area) |
| Bus type | Separate bus/multiplexed bus | | Separate bus |
| Data bus width | 8-bit/16-bit | | 8-bit/16-bit |
| Data bus width setting | Set in CSn control registers (n = 0 to 3) | | Settable by area using bus width control register |
| Address buses | 8 to 24, selectable | | 8 to 24, selectable* ¹ |
| Chip select output | 4 | | 8 |
| Endian setting | Each data area can be set as little-endian or big-endian. | | Big-endian |
| Write access modes* ² | Byte strobe mode | Pins used: WR0# and WR1# | By the following write signals: $\overline{\text{HWR}}$ and $\overline{\text{LWR}}$ |
| | Single-write strobe mode | Pins used: BC0#, BC1#, and WR# | |
| Wait cycles | WAIT# pin | | $\overline{\text{WAIT}}$ pin |
| Software wait time | Up to 31 cycles of wait time | | Settable at 0 to 7 states by area |
| Idle cycles (recovery cycles) | Ability to insert up to 15 cycles (selectable among 8 patterns) | | Ability to insert idle cycles of up to 2 states each (selectable among 3 patterns) |
| Page access | Available | | Not available |
| Bus request (BREQ) | Not available | | Request signal asking that bus mastership be released to the external bus master |
| Bus request acknowledge (BACK) | Not available | | Acknowledge signal indicating that bus mastership was released to the external bus master |
| Bus request output (BREQO) | Not available | | External bus request signal to allow the internal bus master to access the external address space when the external bus is in the released state |

Note 1. The number of usable buses is limited by the operating mode.

Note 2. For details, see 1.1.1, 16-Bit Bus Connection Examples.

1.1 External Bus Connection Examples

1.1.1 16-Bit Bus Connection Examples

Figure 1.1 and Figure 1.2 show examples of connection to external memory with byte selection on the H8S/2378 Series and RX231 Group.

In order to use byte strobe mode on the H8S/2378 Series or RX231 Group it is necessary to connect the read and write strobe signals to the \overline{WE} , \overline{LB} , and \overline{UB} pins of the of the external memory, and a circuit must be configured for this purpose. On the RX231 Group it is not necessary to connect a circuit between the microcontroller and the external memory when single-write strobe mode is used as the write access mode.

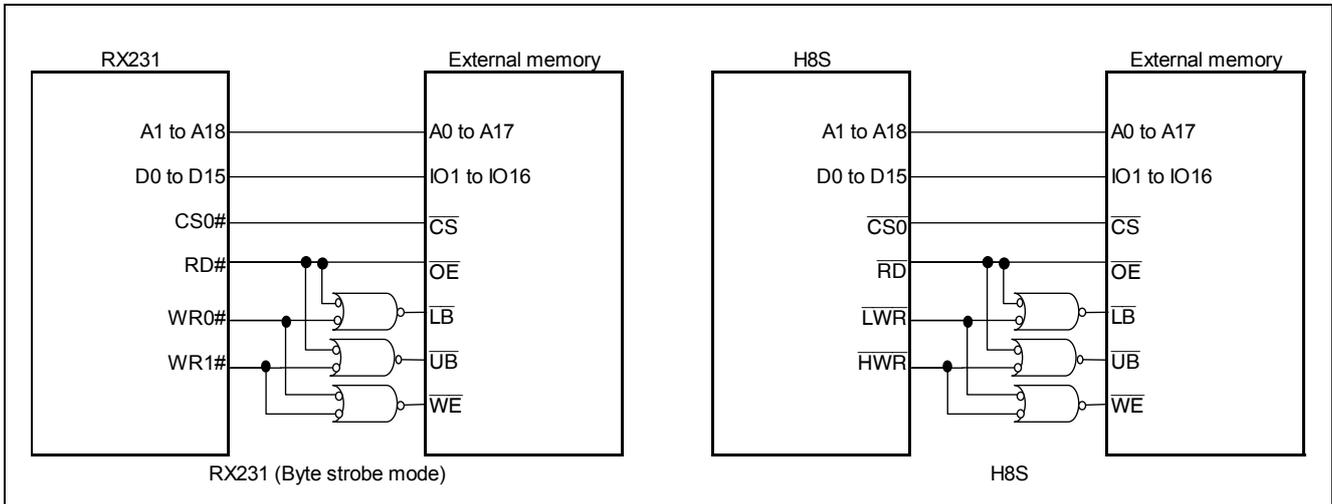


Figure 1.1 H8S/2378 Series and RX231 Group Connection Examples (Byte Strobe Mode)

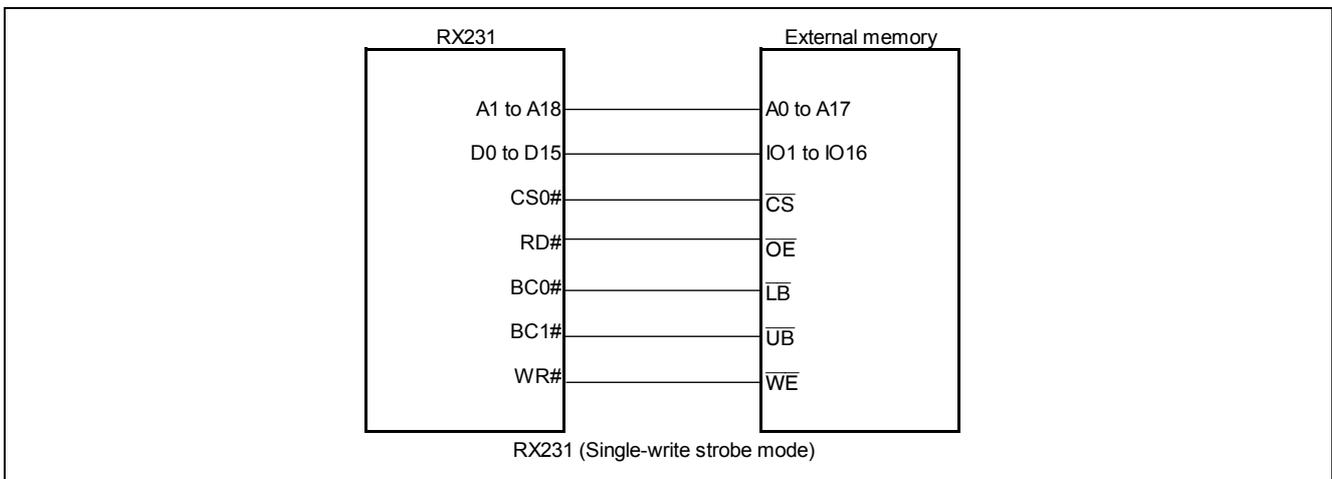


Figure 1.2 RX231 Group Connection Examples (Single-Write Strobe Mode)

1.1.2 8-Bit Bus Connection Examples

Figure 1.3 shows examples of connection via an 8-bit bus on the RX231 Group and H8S/2378 Series. On the RX231 Group the access mode should be set to byte strobe mode. In this case WR0# is enabled during write access. On the H8S/2378 Series HWR is enabled.

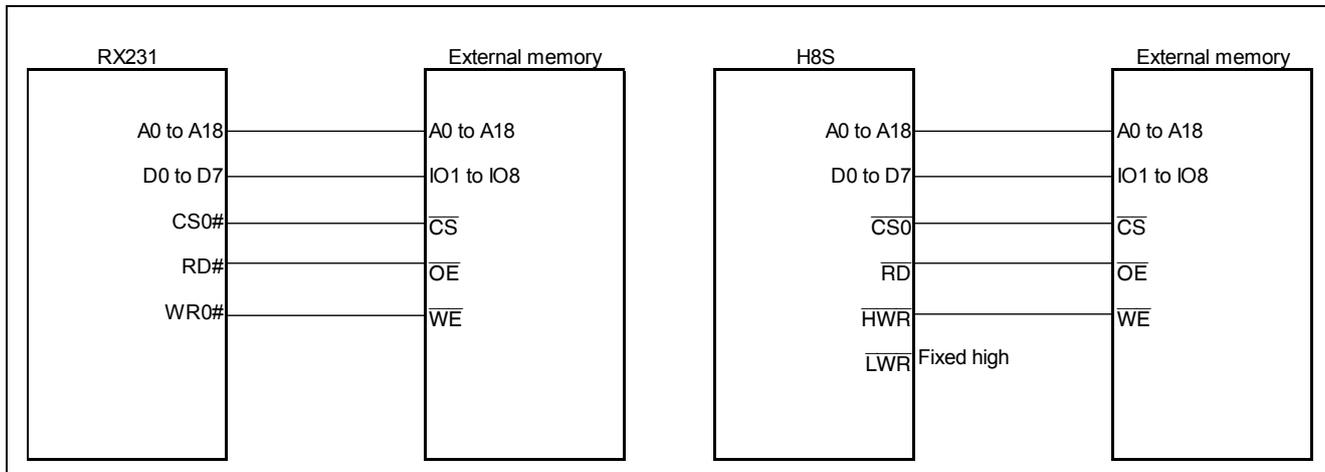


Figure 1.3 8-Bit Bus Connection Examples

1.2 Bus Timing Comparison

The bus timing on the basic bus interface of the H8S/2378 Series and RX231 Group is compared below.

The following example shows 3-state access on the H8S/2378 Series and single-write strobe mode on the RX231 Group. In both cases a 16-bit access space is used, and the big-endian setting is selected on the RX231 Group (the H8S/2378 Series supports big-endian order only). Note that the positions of valid data on the data bus are different when the little-endian setting is selected on the RX231 Group,

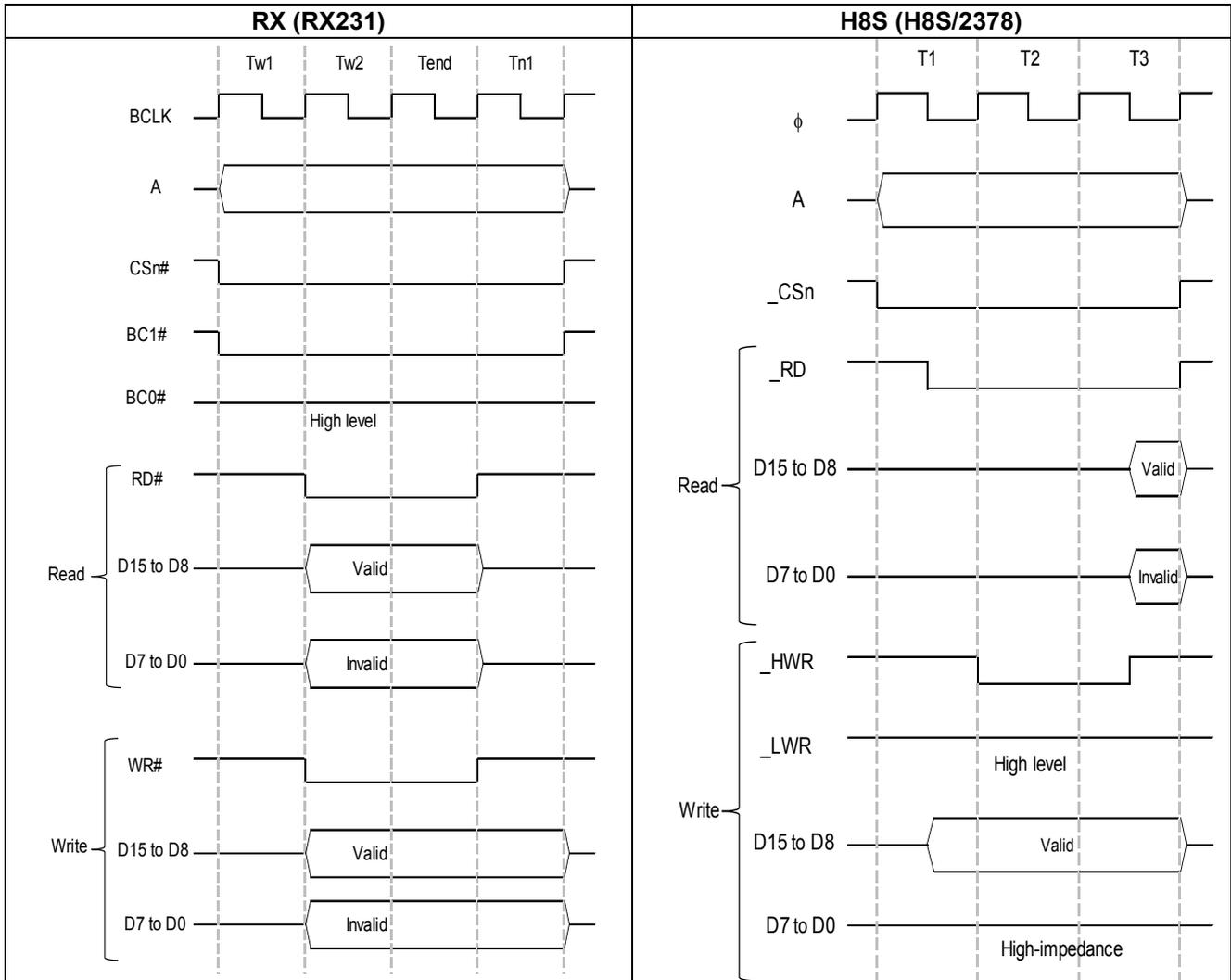


Figure 1.4 Access Timing in 16-Bit Access Space (Even-Number Addresses, Byte Access)

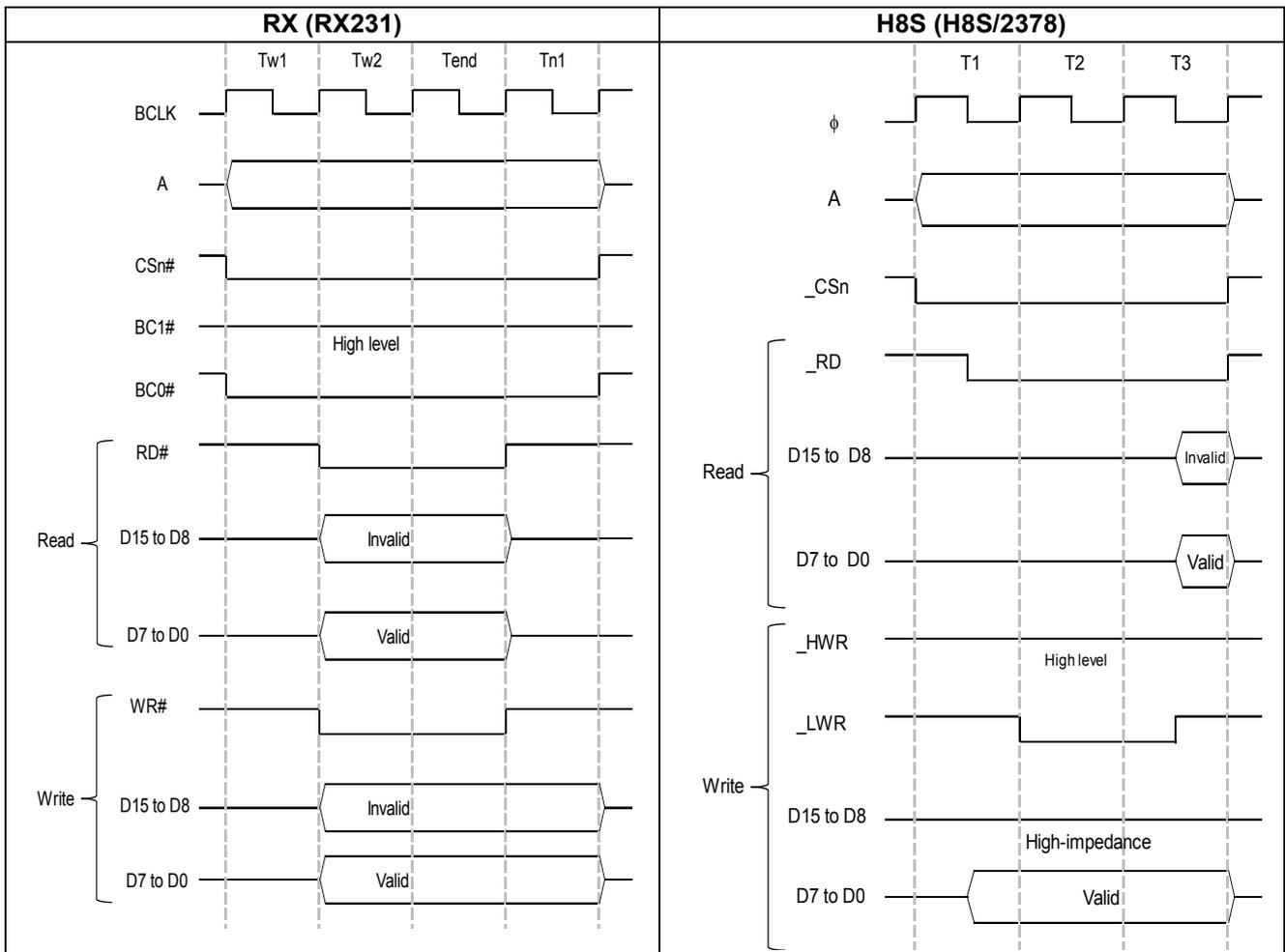


Figure 1.5 Access Timing in 16-Bit Access Space (Odd-Number Addresses, Byte Access)

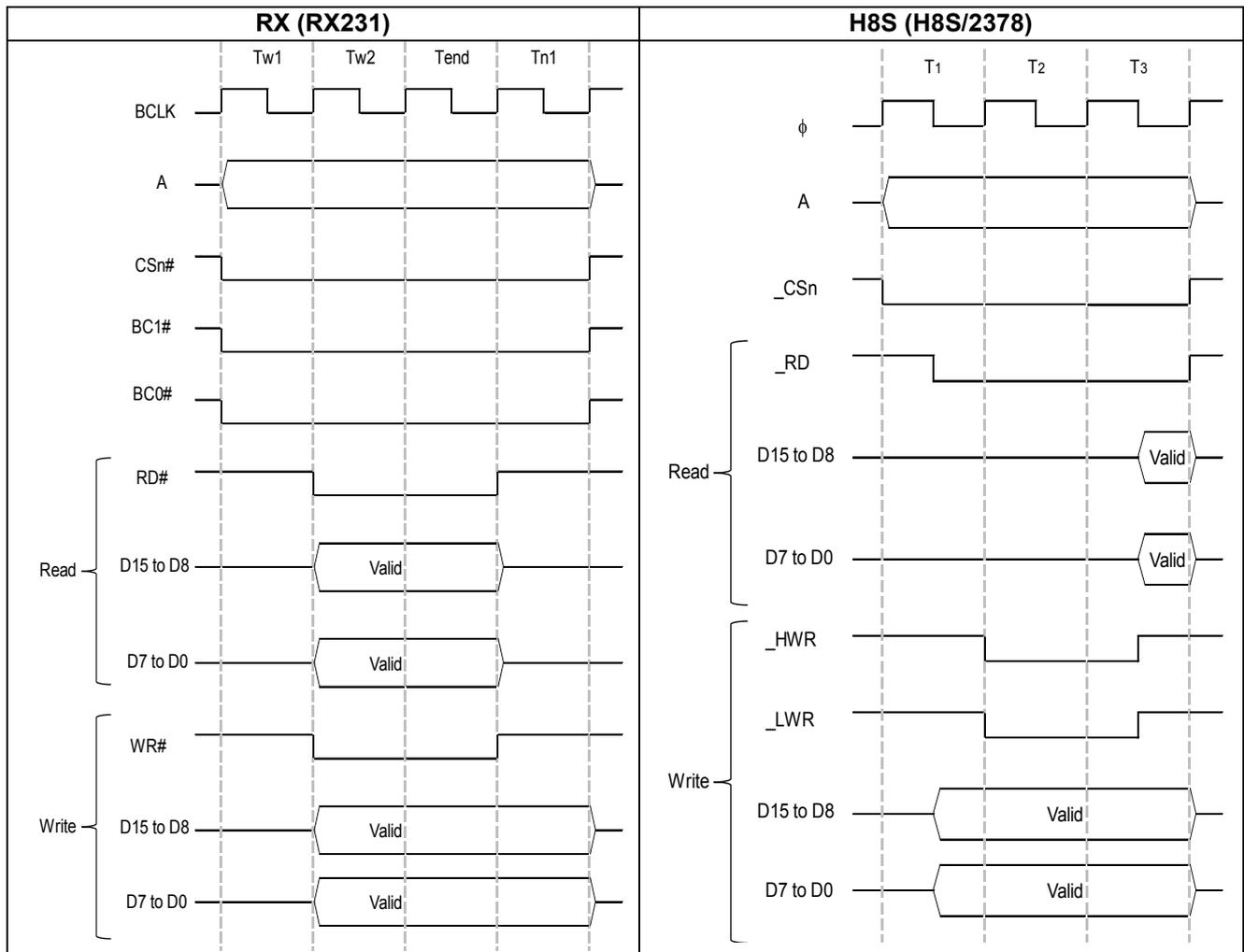


Figure 1.6 Access Timing in 16-Bit Access Space (Even-Number Addresses, Word Access)

When performing word access to odd-number addresses in the 16-bit access space on the RX231 Group, accesses require two bus cycles, in contrast to the above. For details, refer to “Endian and Data Alignment” in the section on buses in User’s Manual: Hardware.

Figure 1.7 compares the access timing when byte strobe mode is selected as the write access mode on the RX231 Group.

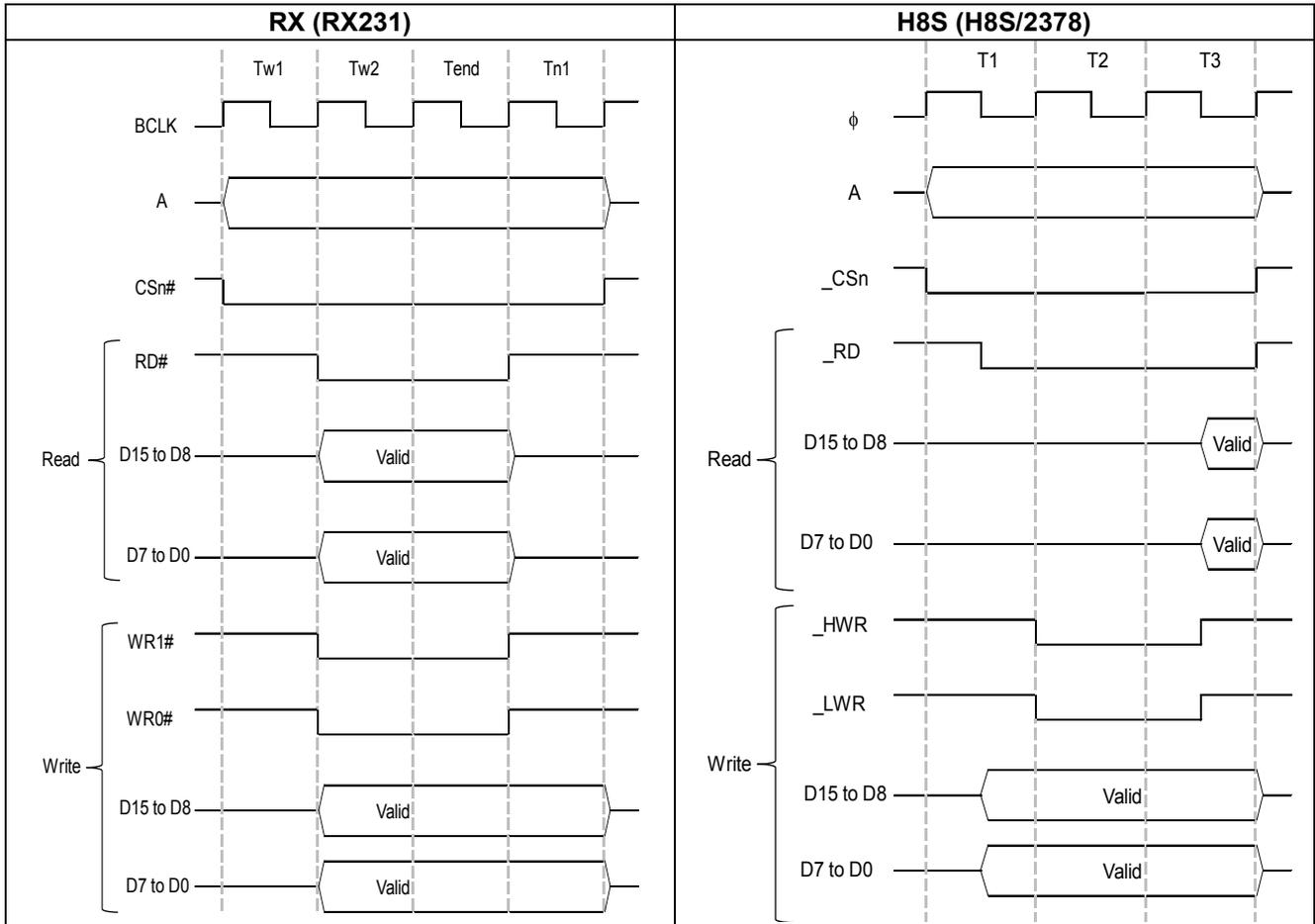


Figure 1.7 Access Timing in Byte Strobe Mode (16-Bit Access Space, Even-Number Addresses, Word Access)

1.3 Calculating Access Cycle Counts

1.3.1 Calculating Access Cycle Counts for Read Accesses

Points of difference between the bus timing settings on the H8S/2378 Series and RX231 Group are shown below, using Figure 1.8, Basic Bus Timing Example (Read Access), as an example.

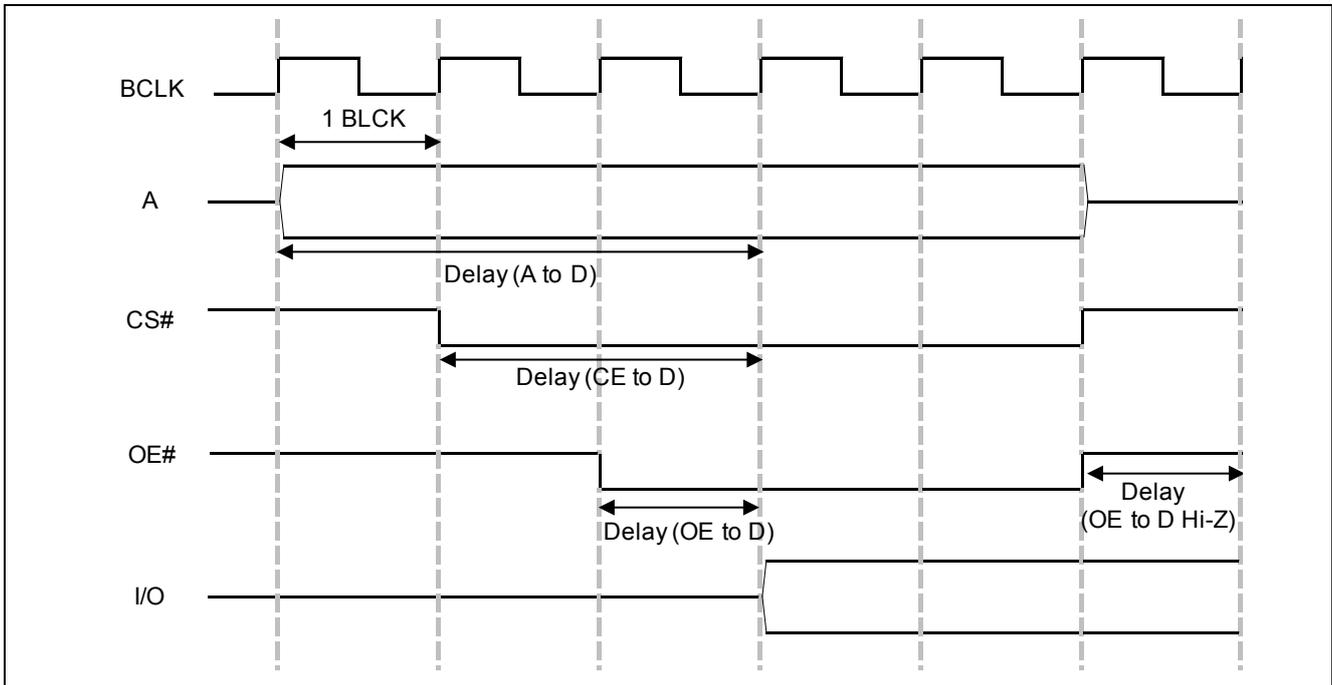


Figure 1.8 Basic Bus Timing Example (Read Access)

Table 1.2 Points of Difference between Bus Timing Related Settings (Read Access)

| RX (RX231) | | H8S (H8S/2378) | |
|------------|---|--|--|
| | | | |
| CSRON | Specifies the number of wait cycles inserted before assertion of the CSn# signal. | T_h | Extension state specified before the basic bus cycle (preceding T_1). Set in the upper 8 bits of CSACR. |
| RDON | Specifies the number of wait cycles inserted before assertion of the RD# signal. | T_t | Extension state specified after the basic bus cycle (following T_3). Set in the lower 8 bits of CSACR. |
| CSRWAIT | Specifies the number of cycles inserted in the first access of a normal read cycle. | RDNn | Can be used to change the read strobe \overline{RD} negation timing by one half-state. |
| CSROFF | Specifies the number of cycles between negation of the RD# signal and negation of the CSn# signal during read access. | Note 1. Program wait A wait (set in WTCRA and WTCRB) can be inserted by a program after the T_2 state. Note 2. Pin wait insertion When the external address area is accessed while the WAITE bit in BCR is set to 1, a pin wait is inserted at the fall of the last program wait state if the \overline{WAIT} pin is low level. | |

Table 1.3 lists the register setting values on the H8S/2378 Series and RX231 Group when the characteristics of the connected external memory are as follows:

- Delay (A to D) = 50 ns (max.)
- Delay (CE to D) = 50 ns (max.)
- Delay (OE to D) = 30 ns (max.)
- Delay (OE to D Hi_Z) = 20 ns (max.)

Table 1.3 Points of Difference between External Bus Register Setting Values (Example for Read Access, BCLK = 32 MHz)

| RX (RX231) | | H8S (H8S/2378) | |
|------------|---------------------------------|----------------|---------------------------|
| | | | |
| CSn | BSC.CS0WCR2.BIT.CSON = 0; *1 | Th | BSC.CSACR.BIT.CSXH0 = 0; |
| RDn | BSC.CS0WCR2.BIT.RDON = 1; *1 | Tt | BSC.CSACR.BIT.CSXT0 = 0; |
| CSRWAIT | BSC.CS0WCR1.BIT.CSRWAIT = 3; *1 | RDNn | BSC.RDNCR.BIT.RDN0 = 0; |
| CSROFF | BSC.CS0WCR2.BIT.CSROFF = 0; | Program wait | BSC.WCR.BIT.W0 = 000b; *2 |

Note 1. Make settings such that value of CSnWCR2.CSON bits ≤ value of CSnWCR2.RDON bits ≤ value of CSnWCR1.CSRWAIT bits.

Note 2. Program wait is enabled only when 3-state access space (ASTCR.BIT.AST0 = 1) is selected.

Note 3. The register setting examples use register and bit field names that apply when making settings for the CS0 area.

Note 4. The register and bit field names are macro names defined by the development environment. (Register names may differ in some cases.)

1.3.2 Calculating Access Cycle Counts for Write Accesses

Points of difference between the bus timing settings on the H8S/2378 Series and RX231 Group are shown below, using Figure 1.9, Basic Bus Timing Example (Write Access), as an example.

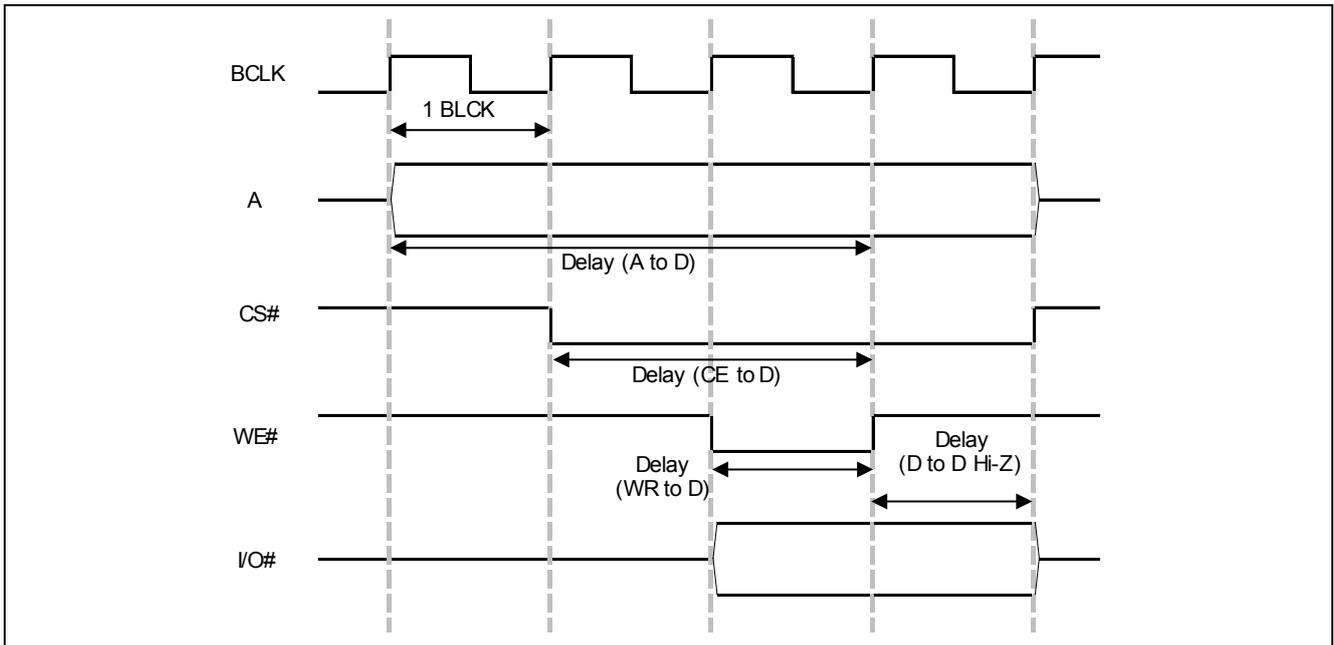


Figure 1.9 Basic Bus Timing Example (Write Access)

Table 1.4 Points of Difference between Bus Timing Related Settings (Write Access)

| RX (RX231) | | H8S (H8S/2378) | |
|------------|--|--|---|
| | | | |
| CSON | Specifies the number of wait cycles inserted before assertion of the CSn# signal. | T _h | Extension state specified before the basic bus cycle (preceding T ₁). Set in the upper 8 bits of CSACR. |
| WDON | Specifies the number of wait cycles inserted before output of write data. | T _t | Extension state specified after the basic bus cycle (following T ₃). Set in the lower 8 bits of CSACR. |
| WRON | Specifies the number of wait cycles inserted before assertion of the WR# signal. | Note 1. Program wait A wait (set in WTCRA and WTCRB) can be inserted by a program after the T ₂ state. Note 2. Pin wait insertion When the external address area is accessed while the WAITE bit in BCR is set to 1, a pin wait is inserted at the fall of the last program wait state if the $\overline{\text{WAIT}}$ pin is low level. | |
| WDOFF | Specifies the number of cycles between negation of the WR# signal and completion of write data output during write access. | | |
| CSWWAIT | Specifies the number of cycles inserted in the first access of a normal write cycle. | | |
| CSWOFF | Specifies the number of cycles between negation of the WR# signal and negation of the CSn# signal during write access. | | |

Table 1.5 lists the register setting values on the H8S/2378 Series and RX231 Group when the characteristics of the connected external memory are as follows:

- Delay (A to D) = 50 ns (min.)
- Delay (CE to D) = 50 ns (min.)
- Delay (WR to D) = 45 ns (min.)
- Delay (D to D Hi_Z) = 0 ns (min.)

Table 1.5 Points of Difference between External Bus Register Setting Values (Example for Write Access, BCLK = 32 MHz)

| RX (RX231) | | H8S (H8S/2378) | |
|---|---------------------------------|----------------|---------------------------|
| <p style="text-align: center;">n = 0 to 3, m = 0 or 1</p> | | | |
| CSON | BSC.CS0WCR2.BIT.CSON = 0; *1 | Th | BSC.CSACR.BIT.CSXH0 = 0; |
| WDON | BSC.CS0WCR2.BIT.WDON = 1; *1 | Tt | BSC.CSACR.BIT.CSXT0 = 0; |
| WRON | BSC.CS0WCR2.BIT.WRON = 1; *1 | Program wait | BSC.WCR.BIT.W0 = 001b; *3 |
| WDOFF | BSC.CS0WCR2.BIT.WDOFF = 1; *2 | | |
| CSWWAIT | BSC.CS0WCR1.BIT.CSWWAIT = 2; *1 | | |
| CSWOFF | BSC.CS0WCR2.BIT.CSWOFF = 1; *2 | | |

Note 1. Make settings such that $1 \leq \text{value of CSnWCR2.WDON bits} \leq \text{value of CSnWCR2.WRON bits} \leq \text{value of CSnWCR1.CSWWAIT bits}$ and $\text{value of CSnWCR2.CSON bits} \leq \text{value of CSnWCR2.WRON bits} \leq \text{value of CSnWCR1.CSWWAIT bits}$.

Note 2. Make settings such that $\text{value of CSnWCR2.WDOFF bits} \leq \text{value of CSnWCR2.CSWOFF bits}$.

Note 3. Program wait is enabled only when 3-state access space (ASTCR.BIT.AST0 = 1) is selected.

Note 4. The register setting examples use register and bit field names that apply when making settings for the CS0 area.

Note 5. The register and bit field names are macro names defined by the development environment. (Register names may differ in some cases.)

1.3.3 Idle Cycles (Recovery Cycles)

On the H8S/2378 Series and RX231 Group the specification for idle cycles (called recovery cycles on the RX231 Group) extends the period following CS negation.

On the H8S/2378 Series idle cycles of one or two states each can be inserted. The insertion condition can be selected among the following three patterns:

- When consecutive external read cycles are performed in different areas
- When an external read cycle and external write cycle are performed consecutively
- When an external write cycle and external read cycle are performed consecutively

On the RX231 Group a recovery cycle of one to 15 cycles can be inserted. The insertion condition can be selected among the following eight options:

- When, after a read access to the external bus, a read access is made to the same external bus area
- When, after a read access to the external bus, a write access is made to the same external bus area
- When, after a read access to the external bus, a read access is made to a different external bus area
- When, after a read access to the external bus, a write access is made to a different external bus area
- When, after a write access to the external bus, a read access is made to the same external bus area
- When, after a write access to the external bus, a write access is made to the same external bus area
- When, after a write access to the external bus, a read access is made to a different external bus area
- When, after a write access to the external bus, a write access is made to a different external bus area

2. Operating Modes

2.1 Comparison of Operating Modes

On the H8S/2378 Series the microcontroller's operating mode is specified as 1 to 5 or 7 by the setting of the mode pins (MD2 to MD0). In addition, external bus mode can be specified by a program by setting the EXPE bit (external bus mode enable) in SYSCR.

On the RX231 Group boot mode (USB/SCI) or single-chip mode are selected by the state of the mode setting pins (MD and UB), and after a reset the device starts in a state in which the on-chip ROM is enabled and the external bus is disabled. In either of these modes the on-chip ROM and the external bus can be enabled or disabled by a program by setting the ROME bit (on-chip ROM enable/disable bit) and EXBE bit (external bus enable/disable bit) in SYSCR0.

Table 2.1 lists the H8S/2378 Series mode pin settings and corresponding operating modes after a reset. In external extended mode each area of the external bus can be set to either 8-bit or 16-bit width by setting the bus controller's ABWCR (bus width control register).

Table 2.1 H8S/2378 Series Mode Pin Settings and Operating Modes (After a Reset)

| MD[2:0] | Operating Mode | On-Chip ROM | External Bus |
|---------|--------------------------------------|-------------|------------------------|
| 001b | 1 On-chip ROM disabled extended mode | Disabled | Enabled (16-bit) |
| 010b | 2 On-chip ROM disabled extended mode | | Enabled (8-bit) |
| 011b | 3 Boot mode | Enabled | Disabled* ¹ |
| 100b | 4 On-chip ROM enabled extended mode | | Enabled (8-bit) |
| 101b | 5 User boot mode | | Disabled* ¹ |
| 111b | 7 Single-chip mode | | Disabled* ¹ |

Note 1. Setting the EXPE bit in SYSCR to 1 enables external extended mode and enables the external address space.

Note 2. The state of pins MD2 to MD0 must not be changed while the microcontroller is operating.

Table 2.2 lists the RX231 Group mode setting pin settings and corresponding operating modes after a reset, and Table 2.3 lists the settings that can be used by programs to enable or disable the ROM and external bus. By making the settings shown in Table 2.3 after the microcontroller starts in single-chip mode, a program can put the device into on-chip ROM enabled extended mode or on-chip ROM disabled extended mode.

Table 2.2 RX231 Group Mode Setting Pin Settings and Operating Modes (After a Reset)

| MD | UB | Operating Mode | On-Chip ROM | External Bus |
|----|----|---------------------------|-------------|--------------|
| 0 | 0 | Boot mode (USB interface) | Enabled | Disabled |
| 0 | 1 | Boot mode (SCI interface) | | |
| 1 | 1 | Single-chip mode | | |

Note: The state of the MD pins must not be changed while the microcontroller is operating.

Table 2.3 RX231 Group Operating Modes and Program Settings

| Item | Program Setting |
|------------------------------------|--|
| Single-chip mode | None |
| On-chip ROM enabled extended mode | Set SYSCR0.ROME bit to 1b and SYSCR0.EXBE bit to 1b. |
| On-chip ROM disabled extended mode | Set SYSCR0.ROME bit to 0b and SYSCR0.EXBE bit to 1b.* ² |

Note 1. The bus width setting is made in the bus control register (CSnCR).

Note 2. This register setting should be made for areas outside the external memory and ROM.

2.2 Functional Points of Difference between Operating Modes

Table 2.4 lists functional points of difference between operating modes when using external memory and on-chip memory on the RX231 Group and H8S/2378 Series, and Table 2.5 lists functional points of difference between operating modes when using external memory only on the RX231 Group and H8S/2378 Series.

Table 2.4 Functional Points of Difference between Operating Modes when Using External Memory and On-Chip Memory (RX231 Group and H8S/2378 Series)

| | RX (RX231) | H8S (H8S/2378) |
|-----------------------|--|--|
| Item | On-Chip ROM Enabled Extended Mode | Mode 4 (On-Chip ROM Enabled Extended Mode) |
| Access areas | I/O registers, on-chip RAM, on-chip ROM, external area | I/O registers, on-chip RAM* ¹ , on-chip ROM, external area |
| External memory areas | 0500 0000h to 07FF FFFFh (CS1 to CS3) | 080000h to FF3FFFh FF4000h to FFBFFFh* ² FFD000h to FFFBFFh FFFF00h to FFFF1Fh |

Note 1. Enabled only when RAME bit in SYSCR is set to 1.

Note 2. External address space when RAME bit in SYSCR is cleared to 0.

Table 2.5 Functional Points of Difference between Operating Modes when Using External Memory Only (RX231 Group and H8S/2378 Series)

| | RX (RX231) | H8S (H8S/2378) |
|-----------------------|---|--|
| Item | On-Chip ROM Disabled Extended Mode | Mode 1 and 2 (On-Chip ROM Disabled Extended Mode) |
| Access areas | I/O registers, on-chip RAM, on-chip ROM* ¹ , external area | I/O registers, on-chip RAM* ² , external area |
| External memory areas | 0500 0000h to 07FF FFFFh (CS1 to CS3) FF00 0000h to FFFF FFFFh (CS0) | 000000h to FF3FFFh FF4000h to FFBFFFh* ³ FFD000h to FFFBFFh FFFF00h to FFFF1Fh |

Note 1. Enabled at startup only.

Note 2. Enabled only when RAME bit in SYSCR is set to 1.

Note 3. External address space when RAME bit in SYSCR is cleared to 0.

3. External Bus Setting Examples

Table 3.1 lists examples of external bus use in different operating modes.

Table 3.1 External Bus Use in Different Operating Modes

| No. | RX (RX231) Mode | H8S (H8S/2378) Mode | Operation Example | Reference |
|-----|------------------------------------|------------------------------------|--|-----------|
| 1 | On-chip ROM enabled extended mode | On-chip ROM enabled extended mode | Reading of data in external memory by a program in on-chip ROM | 3.1 |
| 2 | On-chip ROM disabled extended mode | On-chip ROM disabled extended mode | Reading of data in external memory by a program in external memory | 3.2 |

3.1 Points of Difference between Setting Procedures (On-Chip ROM Enabled Extended Mode Settings)

Table 3.2 lists points of difference between the setting procedures for on-chip ROM enabled extended mode (16-bit bus width), and Table 3.3 lists points of difference between the setting procedures for on-chip ROM enabled extended mode (8-bit bus width).

Table 3.2 Points of Difference between Setting Procedures for On-Chip ROM Enabled Extended Mode (16-Bit Bus Width) (When Accessing CS1 Area*¹)

| Procedure | RX (RX231) | H8S (H8S/2378) |
|---|---|--|
| 1 Pin settings | High-level input to MD pin | 100b input to MD[2:0] pins |
| 2 Reset cancelation | Low-level → high-level input to RESET pin (RES#) | Low-level → high-level input to RESET pin ($\overline{\text{RES}}$) |
| 3 Clock setting | Set the clock frequency to be used for operation. | |
| 4 External wait setting Write access mode and page access settings* ² | BSC.CS1MOD.BIT.EWENB = 0; BSC.CS1MOD.BIT.WRMOD = 0; BSC.CS1MOD.BIT.PRENB = 0; BSC.CS1MOD.BIT.PWENB = 0; | BSC.BCR.BIT.WAITE = 0; |
| 5 Bus timing settings (common to read and write) | BSC.CS1WCR2.BIT.CSON = 0; | BSC.CSACR.BIT.CSXH1 = 1; BSC.CSACR.BIT.CSXT1 = 1; BSC.WCR.BIT.W1 = 000b; |
| 6 Bus timing settings (write) | BSC.CS1WCR1.BIT.CSWWAIT = 2; BSC.CS1WCR2.BIT.CSWOFF = 1; BSC.CS1WCR2.BIT.WDON = 0; BSC.CS1WCR2.BIT.WRON = 1; BSC.CS1WCR2.BIT.WDOFF = 1; | None |
| 7 Bus timing settings (read) | BSC.CS1WCR1.BIT.CSRWAIT = 2; BSC.CS1WCR2.BIT.CSROFF = 1; BSC.CS1WCR2.BIT.RDON = 0; | BSC.RDNCR.BIT.RDN1 = 0; |
| 8 Idle (recovery) cycle settings | BSC.CS1REC.BIT.RRCV = 0; BSC.CS1REC.BIT.WRCV = 0; BSC.CSRECEN.WORD = 0x0000; | BSC.BCR.BIT.ICIS1 = 0; BSC.BCR.BIT.ICIS0 = 0; BSC.BCR.BIT.ICIS2 = 0; |

| Procedure | RX (RX231) | H8S (H8S/2378) |
|---|--|--|
| 9 Bus pin settings | MPC.PFCSE.BIT.CS1E = 1; MPC.PFAOE0.BYTE = 0xFF; MPC.PFAOE1.BYTE = 0x0F; MPC.PFBCR0.BYTE = 0x11; | BSC.PFCR0.BIT.CS1E = 1; BSC.PFCR2.BIT.ASOR = 1; BSC.PFCR2.BIT.LWROE = 1; BSC.PFCR1.BYTE = 0x0F; PA.DDR = 0x0F; PB.DDR = 0xFF; PC.DDR = 0xFF; PF.DDR = 0x80; PG.DDR = 0x02; |
| 10 Bus width setting Endian setting, bus interface, and operation enabled/disabled settings* ² | BSC.CS1CR.BIT.BSIZE = 0; BSC.CS1CR.BIT.EMODE = 0;* ³ BSC.CS1CR.BIT.MPXEN = 0; BSC.CS1CT.BIT.EXENB = 1; | BSC.ABWCR.BIT.ABW1 = 0; |
| 11 Operating mode switching | SYSTEM.PRCR.WORD = 0xA502;* ⁴ SYSTEM.SYSCR0.WORD = 0x5A03; SYSTEM.PRCR.WORD = 0xA500;* ⁴ | None |

Note 1. On the RX231 Group the CS0 area is disabled in on-chip ROM enabled extended mode.

Note 2. RX231 Group only.

Note 3. Endian settings are made by means of the MDE.MDE[2:0] bits and CSnCR.EMODE bit in the option setting memory.

Note 4. The SYSCR0 register is protected by the write protection function, so it is necessary to disable write protection before overwriting the register and then re-enable write protection afterward. (For more information, see 4.1.4, Register Write Protection Function.)

Note 5. The register and bit field names are macro names defined by the development environment. (Register names may differ in some cases.)

Table 3.3 Points of Difference between Setting Procedures for On-Chip ROM Enabled Extended Mode (8-Bit Bus Width) (When Accessing CS1 Area^{*1})

| Procedure | RX (RX231) | H8S (H8S/2378) |
|--|---|--|
| 1 Pin settings | High-level input to MD pin | 100b input to MD[2:0] pins |
| 2 Reset cancelation | Low-level → high-level input to RESET pin (RES#) | Low-level → high-level input to RESET pin (RES) |
| 3 Clock setting | Set the clock frequency to be used for operation. | |
| 4 External wait setting Write access mode and page access settings ^{*2} | BSC.CS1MOD.BIT.EWENB = 0; BSC.CS1MOD.BIT.WRMOD = 0; BSC.CS1MOD.BIT.PRENB = 0; BSC.CS1MOD.BIT.PWENB = 0; | BSC.BCR.BIT.WAITE = 0; |
| 5 Bus timing settings (common to read and write) | BSC.CS1WCR2.BIT.CSON = 0; | BSC.CSACR.BIT.CSXH1 = 1; BSC.CSACR.BIT.CSXT1 = 1; BSC.WCR.BIT.W1 = 000b; |
| 6 Bus timing settings (write) | BSC.CS1WCR1.BIT.CSWWAIT = 2; BSC.CS1WCR2.BIT.CSWOFF = 1; BSC.CS1WCR2.BIT.WDON = 0; BSC.CS1WCR2.BIT.WRON = 1; BSC.CS1WCR2.BIT.WDOFF = 1; | None |
| 7 Bus timing settings (read) | BSC.CS1WCR1.BIT.CSRWAIT = 2; BSC.CS1WCR2.BIT.CSROFF = 1; BSC.CS1WCR2.BIT.RDON = 0; | BSC.RDNCR.BIT.RDN1 = 0; |
| 8 Idle (recovery) cycle settings | BSC.CS1REC.BIT.RRCV = 0; BSC.CS1REC.BIT.WRCV = 0; BSC.CSRECEN.WORD = 0x0000; | BSC.BCR.BIT.ICIS1 = 0; BSC.BCR.BIT.ICIS0 = 0; BSC.BCR.BIT.ICIS2 = 0; |
| 9 Bus pin settings | MPC.PFCSE.BIT.CS1E = 1; MPC.PFAOE0.BYTE = 0xFF; MPC.PFAOE1.BYTE = 0x0F; MPC.PFBCR0.BYTE = 0x01; | BSC.PFCR0.BIT.CS1E = 1; BSC.PFCR2.BIT.ASOR = 1; BSC.PFCR2.BIT.LWROE = 1; BSC.PFCR1.BYTE = 0x0F; PA.DDR = 0x0F; PB.DDR = 0xFF; PC.DDR = 0xFF; PF.DDR = 0x80; PG.DDR = 0x02; |
| 10 Bus width setting Endian setting, bus interface, and operation enabled/disabled settings ^{*2} | BSC.CS1CR.BIT.BSIZE = 2; BSC.CS1CR.BIT.EMODE = 0; ^{*3} BSC.CS1CR.BIT.MPXEN = 0; BSC.CS1CT.BIT.EXENB = 1; | None (The initial bus width setting is 8-bit.) |
| 11 Operating mode switching | SYSTEM.PRCR.WORD = 0xA502; ^{*4} SYSTEM.SYSCR0.WORD = 0x5A03; SYSTEM.PRCR.WORD = 0xA500; ^{*4} | None |

Note 1. On the RX231 Group the CS0 area is disabled in on-chip ROM enabled extended mode.

Note 2. RX231 Group only.

Note 3. Endian settings are made by means of the MDE.MDE[2:0] bits and CSnCR.EMODE bit in the option setting memory.

Note 4. The SYSCR0 register is protected by the write protection function, so it is necessary to disable write protection before overwriting the register and then re-enable write protection afterward. (For more information, see 4.1.4, Register Write Protection Function.)

Note 5. The register and bit field names are macro names defined by the development environment. (Register names may differ in some cases.)

3.2 Points of Difference between Setting Procedures (On-Chip ROM Disabled Extended Mode Settings)

Table 3.4 lists points of difference between the setting procedures for on-chip ROM disabled extended mode (16-bit bus width), and Table 3.5 lists points of difference between the setting procedures for on-chip ROM disabled extended mode (8-bit bus width).

Table 3.4 Points of Difference between Setting Procedures for On-Chip ROM Disabled Extended Mode (16-Bit Bus Width) (When Accessing CS0 Area)

| Procedure | RX (RX231) | H8S (H8S/2378) |
|---|---|--|
| 1 Pin settings | High-level input to MD pin | 001b input to MD[2:0] pins |
| 2 Reset cancelation | Low-level → high-level input to RESET pin (RES#) | Low-level → high-level input to RESET pin (\overline{RES}) |
| 3 External wait setting Write access mode and page access settings* ¹ | BSC.CS0MOD.BIT.EWENB = 0; BSC.CS0MOD.BIT.WRMOD = 0; BSC.CS0MOD.BIT.PRENB = 0; BSC.CS0MOD.BIT.PWENB = 0; | BSC.BCR.BIT.WAITE = 0; * ³ |
| 4 Bus timing settings (common to read and write) | BSC.CS0WCR2.BIT.CSON = 0; | BSC.ASTCR.BYTE = 0xFF; BSC.WCR.WORD.A = 0x7777;(WTCRA) BSC.WCR.WORD.B = 0x7777;(WTCRB) BSC.CSACR.WORD = 0x0000; * ³ |
| 5 Bus timing settings (write) | BSC.CS0WCR1.BIT.CSWWAIT = 2; BSC.CS0WCR2.BIT.CSWOFF = 1; BSC.CS0WCR2.BIT.WDON = 0; BSC.CS0WCR2.BIT.WRON = 1; BSC.CS0WCR2.BIT.WDOFF = 1; | None |
| 6 Bus timing settings (read) | BSC.CS0WCR1.BIT.CSRWAIT = 2; BSC.CS0WCR2.BIT.CSROFF = 1; BSC.CS0WCR2.BIT.RDON = 0; | BSC.RDNCR.BYTE = 0x00; * ³ |
| 7 Idle (recovery) cycle settings | BSC.CS0REC.BIT.RRCV = 0; BSC.CS0REC.BIT.WRCV = 0; BSC.CSRECEN.WORD = 0x0000; | BSC.BCR.BIT.IDLC = 1; BSC.BCR.BIT.ICIS1 = 1; BSC.BCR.BIT.ICIS0 = 1; BSC.BCR.BIT.ICIS2 = 0; * ³ |
| 8 Bus pin settings | MPC.PFCSE.BIT.CS0E = 1; MPC.PFAOE0.BYTE = 0xFF; MPC.PFAOE1.BYTE = 0x0F; MPC.PFBCR0.BYTE = 0x11; | BSC.PFCR0.BYTE = 0xFF; BSC.PFCR2.BYTE = 0x0E; BSC.PFCR1.BYTE = 0xFF; PA.DDR = 0x00; PB.DDR = 0x00; PC.DDR = 0x00; PD.DDR = 0x00; PE.DDR = 0x00; PF.DDR = 0x80; PG.DDR = 0x01; PH.DDR = 0x00; * ³ |
| 9 Bus width setting Endian setting, bus | BSC.CS1CR.BIT.BSIZE = 0; BSC.CS1CR.BIT.EMODE = 0;* ² | BSC.ABWCR.BYTE = 0x00; * ³ |

| Procedure | RX (RX231) | H8S (H8S/2378) |
|--|--|---|
| interface, and operation enabled/disabled settings* ¹ | BSC.CS1CR.BIT.MPXEN = 0; BSC.CS1CT.BIT.EXENB = 1; | |
| 10 RAM program execution | Transfer to RAM the program that performs processing steps 11 and 12, and jump to it. | None |
| 11 Operating mode switching | SYSTEM.PRCR.WORD = 0xA502;* ⁴ SYSTEM.SYSCR0.WORD = 0x5A02; SYSTEM.PRCR.WORD = 0xA500;* ⁴ | None |
| 12 Jump to first program in external memory to be run | Jump to the previously determined address in external memory. | Read the reset vector (address 0) from external memory and jump to the specified address. |
| — Bus settings for accessing external memory | Access the CS0 area in the specified cycle. | Access CS0 using the initial access timing value. |
| — Clock setting | Set the clock frequency to be used for operation. | |

Note 1. RX231 Group only.

Note 2. Endian settings are made by means of the MDE.MDE[2:0] bits and CSnCR.EMODE bit in the option setting memory.

Note 3. Values shown for each register are initial values. Each register remains set to its initial value when operation starts.

Note 4. The SYSCR0 register is protected by the write protection function, so it is necessary to disable write protection before overwriting the register and then re-enable write protection afterward. (For more information, see 4.1.4, Register Write Protection Function.)

Note 5. The register and bit field names are macro names defined by the development environment. (Register names may differ in some cases.)

Table 3.5 Points of Difference between Setting Procedures for On-Chip ROM Disabled Extended Mode (8-Bit Bus Width) (When Accessing CS0 Area)

| Procedure | RX (RX231) | H8S (H8S/2378) |
|---|---|--|
| 1 Pin settings | High-level input to MD pin | 010b input to MD[2:0] pins |
| 2 Reset cancelation | Low-level → high-level input to RESET pin (RES#) | Low-level → high-level input to RESET pin (RES) |
| 3 External wait setting Write access mode and page access settings | BSC.CS0MOD.BIT.EWENB = 0; BSC.CS0MOD.BIT.WRMOD = 0; BSC.CS0MOD.BIT.PRENB = 0; BSC.CS0MOD.BIT.PWENB = 0; | BSC.BCR.BIT.WAITE = 0; * ³ |
| 4 Bus timing settings (common to read and write) | BSC.CS0WCR2.BIT.CSON = 0; | BSC.ASTCR.BYTE = 0xFF; BSC.WCR.WORD.A = 0x7777;(WTCRA) BSC.WCR.WORD.B = 0x7777;(WTCRB) BSC.CSACR.WORD = 0x0000; * ³ |
| 5 Bus timing settings (write) | BSC.CS0WCR1.BIT.CSWWAIT = 2; BSC.CS0WCR2.BIT.CSWOFF = 1; BSC.CS0WCR2.BIT.WDON = 0; BSC.CS0WCR2.BIT.WRON = 1; BSC.CS0WCR2.BIT.WDOFF = 1; | None |
| 6 Bus timing settings (read) | BSC.CS0WCR1.BIT.CSRWAIT = 2; BSC.CS0WCR2.BIT.CSROFF = 1; BSC.CS0WCR2.BIT.RDON = 0; | BSC.RDNCR.BYTE = 0x00; * ³ |
| 7 Idle (recovery) cycle settings | BSC.CS0REC.BIT.RRCV = 0; BSC.CS0REC.BIT.WRCV = 0; BSC.CSREGEN.WORD = 0x0000; | BSC.BCR.BIT.IDLC = 1; BSC.BCR.BIT.ICIS1 = 1; BSC.BCR.BIT.ICIS0 = 1; BSC.BCR.BIT.ICIS2 = 0; * ³ |
| 8 Bus pin settings | MPC.PFCSE.BIT.CS0E = 1; MPC.PFAOE0.BYTE = 0xFF; MPC.PFAOE1.BYTE = 0x0F; MPC.PFBCR0.BYTE = 0x01; | BSC.PFCR0.BYTE = 0xFF; BSC.PFCR2.BYTE = 0x0E; BSC.PFCR1.BYTE = 0xFF; PA.DDR = 0x00; PB.DDR = 0x00; PC.DDR = 0x00; PD.DDR = 0x00; PE.DDR = 0x00; PF.DDR = 0x80; PG.DDR = 0x01; PH.DDR = 0x00; * ³ |
| 9 Bus width setting Endian setting, bus interface, and operation enabled/disabled settings* ¹ | BSC.CS1CR.BIT.BSIZE = 2; BSC.CS1CR.BIT.EMODE = 0;* ² BSC.CS1CR.BIT.MPXEN = 0; BSC.CS1CT.BIT.EXENB = 1; | BSC.ABWCR.BYTE = 0xFF; * ³ |
| 10 RAM program execution | Transfer to RAM the program that performs processing steps 11 and 12, and jump to it. | None |

| Procedure | RX (RX231) | H8S (H8S/2378) |
|---|---|---|
| 11 Operating mode switching | SYSTEM.PRCR.WORD = 0xA502;* ⁴ SYSTEM.SYSCR0.WORD = 0x5A02; SYSTEM.PRCR.WORD = 0xA500;* ⁴ | None |
| 12 Jump to first program in external memory to be run | Jump to the previously determined address in external memory. | Read the reset vector (address 0) from external memory and jump to the specified address. |
| — Bus settings for accessing external memory | Access the CS0 area in the specified cycle. | Access CS0 using the initial access timing value. |
| — Clock setting | Set the clock frequency to be used for operation. | |

Note 1. RX231 Group only.

Note 2. Endian settings are made by means of the MDE.MDE[2:0] bits and CSnCR.EMODE bit in the option setting memory.

Note 3. Values shown for each register are initial values. Each register remains set to its initial value when operation starts.

Note 4. The SYSCR0 register is protected by the write protection function, so it is necessary to disable write protection before overwriting the register and then re-enable write protection afterward. (For more information, see 4.1.4, Register Write Protection Function.)

Note 5. The register and bit field names are macro names defined by the development environment. (Register names may differ in some cases.)

4. Appendix

4.1 Key Points when Migrating from H8S to RX

Some points to keep in mind when migrating from the H8S/2378 Series to the RX231 Group are described below.

4.1.1 Interrupts

Interrupts can be accepted on the RX231 Group when the following conditions are met:

- The I flag (PSW.I bit) is set to 1.
- The interrupt is enabled in the IER and IPR registers of the ICU.
- Interrupt requests are enabled by the corresponding peripheral function interrupt request enable bit.

Table 4.1 is a comparative listing of the interrupt generation conditions on the RX231 Group and H8S/2378 Series.

Table 4.1 Comparative Listing of Interrupt Generation Conditions on RX231 Group and H8S/2378 Series

| Item | RX (RX231) | H8S (H8S/2378) |
|--------------------------------------|---|---|
| Interrupt enable bit | Setting the I flag in the PSW register to 1 (enabled) enables acceptance of maskable interrupts. | In interrupt control mode 0, setting the I flag to 0 (enabled) in the CCR register enables acceptance of maskable interrupts. In interrupt control mode 2 the I flag in the CCR register is not used. |
| Processor interrupt priority level | Only interrupt requests with a higher priority level than that indicated by the IPL[3:0] bits in the PSW register are accepted. | In interrupt control mode 2 only interrupt requests with a higher priority level than that indicated by bits I2 to I0 in the EXR register are accepted. In interrupt control mode 0 the bits I2 to I0 in the EXR register is not used. |
| Interrupt request flag | The interrupt controller manages all interrupt status flags for peripheral functions, external pins, NMI interrupts, etc. | The interrupt controller manages interrupt status flags for external interrupts, and interrupt status flags for internal interrupt sources are managed within each on-chip peripheral function. |
| Interrupt priority level | Set in the IPR register. | In interrupt control mode 0 the default settings are used. In interrupt control mode 2 the IPR register settings are used. |
| Interrupt request enable | Set in the IER register for maskable interrupts and in the NMIER register for non-maskable interrupts. | IRQ interrupts are enabled by settings in the IER register. |
| Peripheral function interrupt enable | Interrupts can be enabled or disabled by each peripheral function. | |

For details, refer to the sections on the interrupt controller (ICU), CPU, and peripheral functions in User's Manual: Hardware.

4.1.2 I/O Ports

On the RX231 Group it is necessary to make settings to the MPC in order to assign peripheral function I/O signals to pins.

The following two settings should be made before performing pin I/O control on the RX231 Group:

- PFS register of MPC: Selection of peripheral function to be assigned to the relevant pin
- PMR register of I/O port: Selection of whether the relevant pin will be assigned to a general I/O port or to a peripheral function

Table 4.2 is a comparative listing of peripheral function pin I/O settings on the RX231 Group and H8S/2378 Series.

Table 4.2 Comparative Listing of Peripheral Function Pin I/O Settings on RX231 Group and H8S/2378 Series

| Function | RX (RX231) | H8S (H8S/2378) |
|--|---|---|
| Pin function selection | I/O pins for peripheral functions can be assigned from a selection of multiple pins by making settings in the PFS register. | Pins can be switched between general I/O port and peripheral function settings and pin functions selected through combinations of the MCU operating mode, the setting of the SYSCR.EXPE bit, the PFCR registers, the DDR registers, and the settings of the various peripheral functions. |
| General I/O port/peripheral function switching | Settings in the PMR register can be used to select whether specific pins are used as I/O ports or as peripheral functions. | |

For details, refer to the sections on the multifunction pin controller (MPC) and I/O ports in User's Manual: Hardware.

4.1.3 Module Stop Function

On the RX231 Group it is possible to halt the functioning of individual peripheral modules.

Power consumption can be reduced by transitioning unused modules to the module stop state.

Most modules are in the module stop state after a reset.

It is not possible to read or write to the registers of a module when it is in the module stop state.

For details, refer to the section on low power consumption functions in User's Manual: Hardware.

4.1.4 Register Write Protection Function

On the RX231 Group it is possible to protect important registers from being overwritten if program runaway occurs. The protect register (PRCR) is used to specify the registers that are protected by this function.

For details, refer to the section on the register write protection function in User's Manual: Hardware.

4.2 I/O Register Macros

The macro definitions listed below are contained in the I/O register definition file (iodefine.h) of the RX231 Group. Using macro definitions can make program code easier to read. Table 4.3 lists macro usage examples.

Table 4.3 Macro Usage Examples

| Macro | Usage Example |
|---------------------------------|--|
| IR("module name", "bit name") | IR(MTU0, TGIA0) = 0; Clears the IR bit corresponding to TGIA0 of MTU0 to 0 (clear interrupt request). |
| DTCE("module name", "bit name") | DTCE(MTU0, TGIA0) = 1; Sets the DTCE bit corresponding to TGIA0 of MTU0 to 1 (enable DTC start). |
| IEN("module name", "bit name") | IEN(MTU0, TGIA0) = 1; Sets the IEN bit corresponding to TGIA0 of MTU0 to 1 (enable interrupt). |
| IPR("module name", "bit name") | IPR(MTU0, TGIA0) = 0x02; Sets the IPR bits corresponding to TGIA0 of MTU0 to 2 (interrupt priority level 2). |
| MSTP("module name") | MSTP(MTU) = 0; Clears the module stop setting bit of MTU0 to 0 (cancel module stop state). |
| VECT("module name", "bit name") | #pragma interrupt(Excep_MTU0_TGIA0(vect=VECT(MTU0, TGIA0))) Declares the interrupt function corresponding to TGIA0 of MTU0. |

4.3 Interrupt Functions

On the RX231 Group interrupt functions are provided to implement control register settings or special instructions. To use these interrupt functions, include the file machine.h.

Table 4.4 lists (examples of) points of difference between control register settings and special instructions on the RX231 Group and H8S/2378 Series.

Table 4.4 Points of Difference between Control Register Settings and Special Instructions on RX231 Group and H8S/2378 Series

| Item | Format | |
|-----------------------------|-------------------------------|--|
| | RX (RX231) | H8S (H8S/2378) |
| Set I flag to 1. | setpsw_i(); * ¹ | set_imask_ccr(1); * ¹ * ² |
| Clear I flag to 0. | clrpsw_i(); * ¹ | set_imask_ccr(0); * ¹ * ² |
| Expand to WAIT instruction. | wait(); * ¹ | None |
| Expand to NOP instruction. | nop(); * ¹ | nop(); * ¹ |

Note 1. It is necessary to include the file machine.h.

Note 2. I = 1 means enable interrupts on the RX231 Group, and I = 1 means mask interrupts on the H8S/2378 Series.

5. Reference Documents

User's Manual: Hardware

H8S/2378 Group, H8S/2378R Group Hardware Manual Rev.7.00 (REJ09B0109-0700)

RX230 Group and RX231 Group User's Manual: Hardware Rev.1.10 (R01UH0496EJ0110)

(The latest versions can be downloaded from the Renesas Electronics website.)

Application Note

RX Family, M16C Family Migrating From the M16C Family to the RX Family: External Bus Rev.1.00 (R01AN2100EJ0100)

(The latest versions can be downloaded from the Renesas Electronics website.)

Technical Update/Technical News

(The latest versions can be downloaded from the Renesas Electronics website.)

User's Manual: Development Environment

CC-RX Compiler User's Manual Rev.1.04 (R20UT3248EJ0104)

H8S, H8/300 Series C/C++ Compiler, Assembler, Optimizing Linkage Editor
Compiler Package Ver.6.01 User's Manual (REJ10B0161-0100)

(The latest versions can be downloaded from the Renesas Electronics website.)

Website and Support

Renesas Electronics Website

<http://www.renesas.com/>

Inquiries

<http://www.renesas.com/contact/>

All trademarks and registered trademarks are the property of their respective owners.

Revision History

| Rev. | Date | Description | |
|------|--------------|-------------|----------------------|
| | | Page | Summary |
| 1.00 | Nov. 8, 2017 | — | First edition issued |

General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Handling of Unused Pins

Handle unused pins in accordance with the directions given under Handling of Unused Pins in the manual.

- The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible. Unused pins should be handled as described under Handling of Unused Pins in the manual.

2. Processing at Power-on

The state of the product is undefined at the moment when power is supplied.

- The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the moment when power is supplied.
In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the moment when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the moment when power is supplied until the power reaches the level at which resetting has been specified.

3. Prohibition of Access to Reserved Addresses

Access to reserved addresses is prohibited.

- The reserved addresses are provided for the possible future expansion of functions. Do not access these addresses; the correct operation of LSI is not guaranteed if they are accessed.

4. Clock Signals

After applying a reset, only release the reset line after the operating clock signal has become stable. When switching the clock signal during program execution, wait until the target clock signal has stabilized.

- When the clock signal is generated with an external resonator (or from an external oscillator) during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Moreover, when switching to a clock signal produced with an external resonator (or by an external oscillator) while program execution is in progress, wait until the target clock signal is stable.

5. Differences between Products

Before changing from one product to another, i.e. to a product with a different part number, confirm that the change will not lead to problems.

- The characteristics of Microprocessing unit or Microcontroller unit products in the same group but having a different part number may differ in terms of the internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

Notice

1. Descriptions of circuits, software and other related information in this document are provided only to illustrate the operation of semiconductor products and application examples. You are fully responsible for the incorporation or any other use of the circuits, software, and information in the design of your product or system. Renesas Electronics disclaims any and all liability for any losses and damages incurred by you or third parties arising from the use of these circuits, software, or information.
2. Renesas Electronics hereby expressly disclaims any warranties against and liability for infringement or any other disputes involving patents, copyrights, or other intellectual property rights of third parties, by or arising from the use of Renesas Electronics products or technical information described in this document, including but not limited to, the product data, drawing, chart, program, algorithm, application examples.
3. No license, express, implied or otherwise, is granted hereby under any patents, copyrights or other intellectual property rights of Renesas Electronics or others.
4. You shall not alter, modify, copy, or otherwise misappropriate any Renesas Electronics product, whether in whole or in part. Renesas Electronics disclaims any and all liability for any losses or damages incurred by you or third parties arising from such alteration, modification, copy or otherwise misappropriation of Renesas Electronics products.
5. Renesas Electronics products are classified according to the following two quality grades: "Standard" and "High Quality". The intended applications for each Renesas Electronics product depends on the product's quality grade, as indicated below.
"Standard": Computers; office equipment; communications equipment; test and measurement equipment; audio and visual equipment; home electronic appliances; machine tools; personal electronic equipment; and industrial robots etc.
"High Quality": Transportation equipment (automobiles, trains, ships, etc.); traffic control (traffic lights); large-scale communication equipment; key financial terminal systems; safety control equipment; etc.
Renesas Electronics products are neither intended nor authorized for use in products or systems that may pose a direct threat to human life or bodily injury (artificial life support devices or systems, surgical implantations etc.), or may cause serious property damages (space and undersea repeaters; nuclear power control systems; aircraft control systems; key plant systems; military equipment; etc.). Renesas Electronics disclaims any and all liability for any damages or losses incurred by you or third parties arising from the use of any Renesas Electronics product for which the product is not intended by Renesas Electronics.
6. When using the Renesas Electronics products, refer to the latest product information (data sheets, user's manuals, application notes, "General Notes for Handling and Using Semiconductor Devices" in the reliability handbook, etc.), and ensure that usage conditions are within the ranges specified by Renesas Electronics with respect to maximum ratings, operating power supply voltage range, heat radiation characteristics, installation, etc. Renesas Electronics disclaims any and all liability for any malfunctions or failure or accident arising out of the use of Renesas Electronics products beyond such specified ranges.
7. Although Renesas Electronics endeavors to improve the quality and reliability of Renesas Electronics products, semiconductor products have specific characteristics such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Further, Renesas Electronics products are not subject to radiation resistance design. Please ensure to implement safety measures to guard them against the possibility of bodily injury, injury or damage caused by fire, and social damage in the event of failure or malfunction of Renesas Electronics products, such as safety design for hardware and software including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other appropriate measures by your own responsibility as warranty for your products/system. Because the evaluation of microcomputer software alone is very difficult and not practical, please evaluate the safety of the final products or systems manufactured by you.
8. Please contact a Renesas Electronics sales office for details as to environmental matters such as the environmental compatibility of each Renesas Electronics product. Please investigate applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive carefully and sufficiently and use Renesas Electronics products in compliance with all these applicable laws and regulations. Renesas Electronics disclaims any and all liability for damages or losses occurring as a result of your noncompliance with applicable laws and regulations.
9. Renesas Electronics products and technologies shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations. You shall not use Renesas Electronics products or technologies for (1) any purpose relating to the development, design, manufacture, use, stockpiling, etc., of weapons of mass destruction, such as nuclear weapons, chemical weapons, or biological weapons, or missiles (including unmanned aerial vehicles (UAVs)) for delivering such weapons, (2) any purpose relating to the development, design, manufacture, or use of conventional weapons, or (3) any other purpose of disturbing international peace and security, and you shall not sell, export, lease, transfer, or release Renesas Electronics products or technologies to any third party whether directly or indirectly with knowledge or reason to know that the third party or any other party will engage in the activities described above. When exporting, selling, transferring, etc., Renesas Electronics products or technologies, you shall comply with any applicable export control laws and regulations promulgated and administered by the governments of the countries asserting jurisdiction over the parties or transactions.
10. Please acknowledge and agree that you shall bear all the losses and damages which are incurred from the misuse or violation of the terms and conditions described in this document, including this notice, and hold Renesas Electronics harmless, if such misuse or violation results from your resale or making Renesas Electronics products available any third party.
11. This document shall not be reprinted, reproduced or duplicated in any form, in whole or in part, without prior written consent of Renesas Electronics.
12. Please contact a Renesas Electronics sales office if you have any questions regarding the information contained in this document or Renesas Electronics products.
(Note 1) "Renesas Electronics" as used in this document means Renesas Electronics Corporation and also includes its majority-owned subsidiaries.
(Note 2) "Renesas Electronics product(s)" means any product developed or manufactured by or for Renesas Electronics.

(Rev.3.0-1 November 2016)



SALES OFFICES

Renesas Electronics Corporation

<http://www.renesas.com>

Refer to "<http://www.renesas.com/>" for the latest and detailed information.

Renesas Electronics America Inc.

2801 Scott Boulevard Santa Clara, CA 95050-2549, U.S.A.
Tel: +1-408-588-6000, Fax: +1-408-588-6130

Renesas Electronics Canada Limited

9251 Yonge Street, Suite 8309 Richmond Hill, Ontario Canada L4C 9T3
Tel: +1-905-237-2004

Renesas Electronics Europe Limited

Dukes Meadow, Millboard Road, Bourne End, Buckinghamshire, SL8 5FH, U.K.
Tel: +44-1628-585-100, Fax: +44-1628-585-900

Renesas Electronics Europe GmbH

Arcadiastrasse 10, 40472 Düsseldorf, Germany
Tel: +49-211-6503-0, Fax: +49-211-6503-1327

Renesas Electronics (China) Co., Ltd.

Room 1709, Quantum Plaza, No.27 ZhiChunLu Haidian District, Beijing 100191, P.R.China
Tel: +86-10-8235-1155, Fax: +86-10-8235-7679

Renesas Electronics (Shanghai) Co., Ltd.

Unit 301, Tower A, Central Towers, 555 Langao Road, Putuo District, Shanghai, P. R. China 200333
Tel: +86-21-2226-0888, Fax: +86-21-2226-0999

Renesas Electronics Hong Kong Limited

Unit 1601-1611, 16/F., Tower 2, Grand Century Place, 193 Prince Edward Road West, Mongkok, Kowloon, Hong Kong
Tel: +852-2265-6688, Fax: +852 2886-9022

Renesas Electronics Taiwan Co., Ltd.

13F, No. 363, Fu Shing North Road, Taipei 10543, Taiwan
Tel: +886-2-8175-9600, Fax: +886 2-8175-9670

Renesas Electronics Singapore Pte. Ltd.

80 Bendemeer Road, Unit #06-02 Hyflux Innovation Centre, Singapore 339949
Tel: +65-6213-0200, Fax: +65-6213-0300

Renesas Electronics Malaysia Sdn.Bhd.

Unit 1207, Block B, Menara Amcorp, Amcorp Trade Centre, No. 18, Jln Persiaran Barat, 46050 Petaling Jaya, Selangor Darul Ehsan, Malaysia
Tel: +60-3-7955-9390, Fax: +60-3-7955-9510

Renesas Electronics India Pvt. Ltd.

No.777C, 100 Feet Road, HAL II Stage, Indiranagar, Bangalore, India
Tel: +91-80-67208700, Fax: +91-80-67208777

Renesas Electronics Korea Co., Ltd.

12F., 234 Teheran-ro, Gangnam-Gu, Seoul, 135-080, Korea
Tel: +82-2-558-3737, Fax: +82-2-558-5141